

**Search Notes**

Application/Control No.

10/697,144

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

BECK ET AL.

Art Unit

1752

**SEARCHED**

Class	Subclass	Date	Examiner
430	311	4/24/06	JSC
430	270.1	L	L

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	4/20/06	JSC